Search Notes



Application/Control No.	

10530861

Applicant(s)/Patent Under Reexamination
FUKUSHIMA ET AL.

Examiner

Art Unit

Nguyen, Lauren

2871

SEARCHED

Class	Subclass	Date	Examiner
349	15, 201-202	04/03/2007	LN
359	376, 462	04/03/2007	LN

SEARCH NOTE

Search Notes	Date	Examiner
Consulted Primary Examiner Andrew Schechter	04/03/2007	LN

INITED		NCF SF	
11011 FR	CERE	VI. F 5 F	$\Delta R \cup H$

Class	Subclass	Date	Examiner
	(barrier and light and resin and liquid and crystal).clm.	4/12/2010	LN

/L. N./ Examiner.Art Unit 2871	

U.S. Patent and Trademark Office Part of Paper No. :